

## SNx5HVD308xE 低功耗 RS-485 收发器

### 1 特性

- 符合或超出 TIA/EIA-485A 标准要求
- 低静态功率
  - 有源模式下为 0.3mA
  - 关断模式下为 1nA
- 1/8 单位负载，一条总线上多达 256 个节点
- 高达 15kV 的总线引脚 ESD 保护
- 业界通用通用 SN75176 封装
- 失效防护接收器（总线开路、总线短接、总线空闲）
- 无干扰上电和下电总线输入和输出

### 2 应用

- 能量计网络
- 电机控制
- 电源逆变器
- 工业自动化
- 楼宇自动化网络
- 电池供电的应用
- 电信设备

### 3 说明

SNx5HVD308xE 是专为 RS-485 数据总线网络设计的半双工收发器。这些器件由 5V 电源供电，完全符合 TIA/EIA-485A 标准。通过控制转换时间，这些器件适用于在长双绞线电缆上传输数据。SN65HVD3082E 和 SN75HVD3082E 经过优化，支持高达 200kbps 的信号传输速率。SN65HVD3085E 适用于高达 1Mbps 的数据传输，而 SN65HVD3088E 适用于要求信号传输速率高达 20Mbps 的应用。

这些器件设计为可在非常低的电源电流（通常为 0.3mA，不包括负载）下工作。在非工作关机模式下，电源电流可降至几纳安，使得这些器件是功率敏感型应用的理想之选。

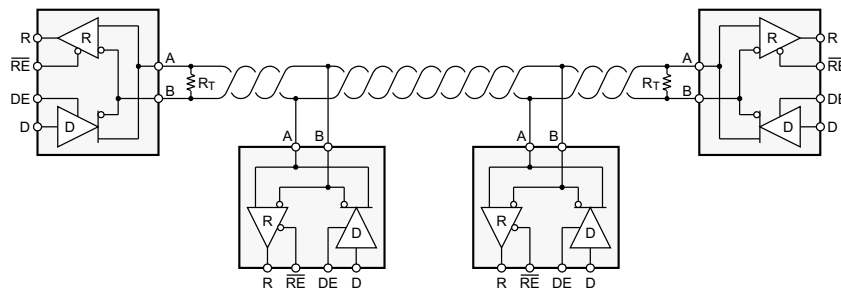
这些器件具有较宽的共模范围和较高的 ESD 保护级别，使其适用于要求苛刻的应用，例如电表网络、电气逆变器、电信机架上的状态和命令信号、有线机箱互连以及噪声容限至关重要的工业自动化网络。这些器件符合 SN75176 器件的业界通用尺寸。上电复位电路使输出保持高阻抗状态，直到电源电压稳定。热关机功能可保护器件免受由于系统故障造成的损坏。SN75HVD3082E 的特点是工作温度范围为 0°C 至 70°C，而 SN65HVD308xE 的特点是工作温度范围为 -40°C 至 85°C。SN65HVD3082E 的 D 封装版本的特点是可在 -40°C 至 105°C 的温度范围内运行。

#### 封装信息

| 器件型号                         | 封装 <sup>(1)</sup> | 封装尺寸 <sup>(2)</sup> |
|------------------------------|-------------------|---------------------|
| SN65HVD3082E                 | SOIC ( D , 8 )    | 4.9 mm × 6 mm       |
|                              | VSSOP ( DGK , 8 ) | 3 mm × 4.9 mm       |
|                              | PDIP ( P , 8 )    | 9.81 mm × 9.43 mm   |
| SN65HVD3088E                 | SOIC ( D , 8 )    | 4.9 mm × 6 mm       |
|                              | VSSOP ( DGK , 8 ) | 3 mm × 4.9 mm       |
|                              | PDIP ( P , 8 )    | 9.81 mm × 9.43 mm   |
|                              | SO ( NS , 14 )    | 10.2 mm × 7.8 mm    |
| SN75HVD3082E<br>SN65HVD3085E | SOIC ( D , 8 )    | 4.9 mm × 6 mm       |
|                              | VSSOP ( DGK , 8 ) | 3 mm × 4.9 mm       |

(1) 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。

(2) 封装尺寸（长 × 宽）为标称值，并包括引脚（如适用）。



简化原理图

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## 4 Revision History

注：以前版本的页码可能与当前版本的页码不同

|                                                                                                                  |             |
|------------------------------------------------------------------------------------------------------------------|-------------|
| <b>Changes from Revision N (June 2023) to Revision O (July 2023)</b>                                             | <b>Page</b> |
| • Changed pins 11 and 12 to NC in the NS Package 图 5-2 和 表 5-2 .....                                             | 4           |
| <b>Changes from Revision M (February 2022) to Revision N (June 2023)</b>                                         | <b>Page</b> |
| • 将“器件信息”表更改为 封装信息 表添加了 NS 封装.....                                                                               | 1           |
| • Added the SN65HVD3088E NS package.....                                                                         | 4           |
| • Added the NS package values to the <i>Thermal Information, SN65HVD308xE</i> table.....                         | 7           |
| <b>Changes from Revision L (November 2021) to Revision M (February 2022)</b>                                     | <b>Page</b> |
| • Added storage temperature $T_{stg}$ to <i>Absolute Maximum Ratings</i> table.....                              | 6           |
| • Changed the <i>Thermal Information, SN65HVD308xE</i> table.....                                                | 7           |
| <b>Changes from Revision K (July 2021) to Revision L (November 2021)</b>                                         | <b>Page</b> |
| • 删除了 特性：采用小型 MSOP-8 封装.....                                                                                     | 1           |
| • 从标题中删除了“采用小型 MSOP-8 封装”.....                                                                                   | 1           |
| • Changed the $\psi_{JT}$ D package value from 78.8 to 8.8 in the <i>Thermal Information, SNx5HVD3082E</i> ..... | 7           |
| <b>Changes from Revision J (October 2017) to Revision K (July 2021)</b>                                          | <b>Page</b> |
| • Changed the <i>Thermal Information</i> tables.....                                                             | 7           |

| <b>Changes from Revision I (September 2016) to Revision J (October 2017)</b> | <b>Page</b>        |
|------------------------------------------------------------------------------|--------------------|
| • Changed 3.3 V to 5 V on the $V_{CC}$ pin in <a href="#">图 9-4</a> .....    | <a href="#">21</a> |

| <b>Changes from Revision H (August 2015) to Revision I (September 2016)</b>                                                                                         | <b>Page</b>       |
|---------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------------|
| • 在 <a href="#">说明</a> 中新增了文本。“SN65HVD3082E 的 D 封装版本的特点是在 $-40^{\circ}\text{C}$ 至 $105^{\circ}\text{C}$ 的温度范围内工作。”.                                                 | <a href="#">1</a> |
| • Changed the Operating free-air temperature for SN65HVD3082E (D package) From: MAX = $85^{\circ}\text{C}$ To: $105^{\circ}\text{C}$ in <a href="#">节 6.3</a> ..... | <a href="#">7</a> |

| <b>Changes from Revision G (May 2009) to Revision H (August 2015)</b>                                                                                                                                                                                       | <b>Page</b>       |
|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------------|
| • 新增了 <a href="#">引脚配置和功能</a> 部分、 <a href="#">ESD 等级表</a> 、 <a href="#">特性说明</a> 部分、 <a href="#">器件功能模式</a> 、 <a href="#">应用和实施</a> 部分、 <a href="#">电源相关建议</a> 部分、 <a href="#">布局</a> 部分、 <a href="#">器件和文档支持</a> 部分以及 <a href="#">机械、封装和可订购信息</a> 部分 ..... | <a href="#">1</a> |
| • 删除了 <a href="#">功耗额定值表</a> .....                                                                                                                                                                                                                          | <a href="#">1</a> |
| • Deleted <i>Package Thermal Information</i> table .....                                                                                                                                                                                                    | <a href="#">8</a> |

| <b>Changes from Revision F (March 2009) to Revision G (May 2009)</b>  | <b>Page</b>        |
|-----------------------------------------------------------------------|--------------------|
| • Added Graph - <i>Driver Rise and Fall Time vs Temperature</i> ..... | <a href="#">11</a> |
| • Added IDLE Bus to the <i>Function Table</i> .....                   | <a href="#">17</a> |
| • Added <i>Receiver Fail-safe</i> section .....                       | <a href="#">21</a> |

## 5 Pin Configuration and Functions

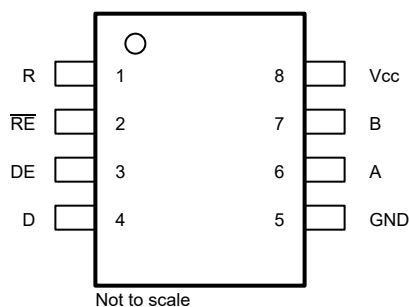
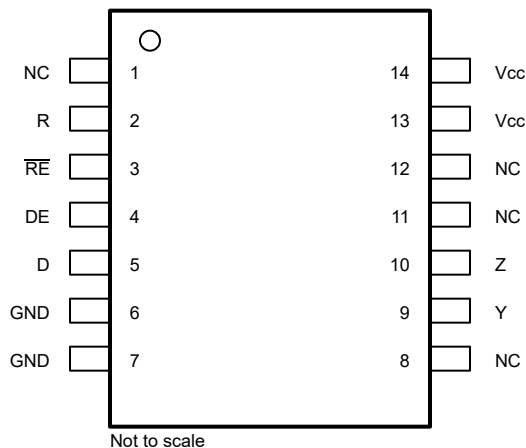


图 5-1. D (SOIC), P (PDIP), and DGK (VSSOP) Packages, 8-Pin (Top View)

表 5-1. Pin Functions

| PIN             |     | TYPE                | DESCRIPTION                                          |
|-----------------|-----|---------------------|------------------------------------------------------|
| NAME            | NO. |                     |                                                      |
| R               | 1   | Digital output      | Receive data output                                  |
| RE              | 2   | Digital input       | Receiver enable, active low                          |
| DE              | 3   | Digital input       | Driver enable, active high                           |
| D               | 4   | Digital input       | Driver data input                                    |
| GND             | 5   | Reference potential | Local device ground                                  |
| A               | 6   | Bus input/output    | Driver output or receiver input (complementary to B) |
| B               | 7   | Bus input/output    | Driver output or receiver input (complementary to A) |
| V <sub>CC</sub> | 8   | Supply              | 4.5-V to 5.5-V supply                                |



**图 5-2. SN65HVD3088E, NS Package, 14-pin  
(Top View)**

**表 5-2. Pin Functions, NS Package**

| PIN             |        | TYPE                | DESCRIPTION                                                    |
|-----------------|--------|---------------------|----------------------------------------------------------------|
| NAME            | NO.    |                     |                                                                |
| NC              | 1, 8   | No Connect          | Not Electrically Connected                                     |
| R               | 2      | Digital output      | Receive data output                                            |
| RE              | 3      | Digital input       | Receiver enable, active low                                    |
| DE              | 4      | Digital input       | Driver enable, active high                                     |
| D               | 5      | Digital input       | Driver data input                                              |
| GND             | 6, 7   | Reference potential | Local device ground                                            |
| Y               | 9      | Bus I/O             | Differential transceiver input and output (complementary to Z) |
| Z               | 10     | Bus I/O             | Differential transceiver input and output (complementary to Y) |
| NC              | 12     | No Connect          | Not Electrically Connected                                     |
| NC              | 11     | No Connect          | Not Electrically Connected                                     |
| V <sub>CC</sub> | 13, 14 | Supply              | 4.5-V to 5.5-V supply                                          |

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range unless otherwise noted<sup>(1) (2)</sup>

|                                                                                                  | MIN  | MAX            | UNIT |
|--------------------------------------------------------------------------------------------------|------|----------------|------|
| Supply voltage, $V_{CC}$                                                                         | -0.5 | 7              | V    |
| Voltage at A or B                                                                                | -9   | 14             | V    |
| Voltage at any logic pin                                                                         | -0.3 | $V_{CC} + 0.3$ | V    |
| Receiver output current                                                                          | -24  | 24             | mA   |
| Voltage input, transient pulse, A and B, through 100 $\Omega$ (see <a href="#">Figure 7-13</a> ) | -50  | 50             | V    |
| Junction Temperature, $T_J$                                                                      |      | 170            | °C   |
| Storage temperature, $T_{stg}$                                                                   | -65  | 150            | °C   |

- (1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. *Absolute Maximum Ratings* do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If used outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) All voltage values, except differential I/O bus voltages, are with respect to network ground terminal.

### 6.2 ESD Ratings

|                                     |                                                                                |                  | VALUE  | UNIT |
|-------------------------------------|--------------------------------------------------------------------------------|------------------|--------|------|
| $V_{(ESD)}$ Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>              | Bus pins and GND | ±15000 | V    |
|                                     |                                                                                | All pins         | ±4000  |      |
|                                     | Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup> |                  | ±1000  |      |
|                                     | Electrical Fast Transient/Burst, A, B, and GND <sup>(3)</sup>                  |                  | ±4000  |      |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.
- (3) Tested in accordance with IEC 61000-4-4.

## 6.3 Recommended Operating Conditions

over operating free-air temperature range unless otherwise noted<sup>(1)</sup>

|                                                                       |                                                                  | MIN | NOM | MAX      | UNIT               |
|-----------------------------------------------------------------------|------------------------------------------------------------------|-----|-----|----------|--------------------|
| Supply voltage, $V_{CC}$                                              |                                                                  | 4.5 |     | 5.5      | V                  |
| Voltage at any bus terminal (separately or common mode), $V_I$        |                                                                  | –7  |     | 12       |                    |
| High-level input voltage (D, DE, or $\overline{RE}$ inputs), $V_{IH}$ |                                                                  | 2   |     | $V_{CC}$ | V                  |
| Low-level input voltage (D, DE, or $\overline{RE}$ inputs), $V_{IL}$  |                                                                  | 0   |     | 0.8      | V                  |
| Differential input voltage, $V_{ID}$                                  |                                                                  | –12 |     | 12       | V                  |
| Output current, $I_O$                                                 | Driver                                                           | –60 |     | 60       | mA                 |
|                                                                       | Receiver                                                         | –8  |     | 8        |                    |
| Differential load resistance, $R_L$                                   |                                                                  | 54  | 60  |          | $\Omega$           |
| Signaling rate, $1/t_{UI}$                                            | SN65HVD3082E, SN75HVD3082E                                       |     |     | 0.2      | Mbps               |
|                                                                       | SN65HVD3085E                                                     |     |     | 1        |                    |
|                                                                       | SN65HVD3088E                                                     |     |     | 20       |                    |
| Operating free-air temperature, $T_A$                                 | SN65HVD3082E (D package)                                         | –40 |     | 105      | $^{\circ}\text{C}$ |
|                                                                       | SN65HVD3082E (DGK and P packages),<br>SN65HVD3085E, SN65HVD3088E | –40 |     | 85       |                    |
|                                                                       | SN75HVD3082E                                                     | 0   |     | 70       |                    |
| Junction temperature, $T_J$                                           |                                                                  | –40 |     | 130      | $^{\circ}\text{C}$ |

(1) The algebraic convention, in which the least positive (most negative) limit is designated as minimum is used in this data sheet.

## 6.4 Thermal Information, SN65HVD308xE

| THERMAL METRIC <sup>(1)</sup> |                                              | SN65HVD3085E, SN65HVD3088E |             | SN65HVD3088E | SN65HVD3088E | UNIT                        |
|-------------------------------|----------------------------------------------|----------------------------|-------------|--------------|--------------|-----------------------------|
|                               |                                              | D (SOIC)                   | DGK (VSSOP) | P (PDIP)     | NS (SO)      |                             |
|                               |                                              | 8 PINS                     | 8 PINS      | 8 PINS       | 14 PINS      |                             |
| $R_{\theta JA}$               | Junction-to-ambient thermal resistance       | 116.7                      | 137.8       | 84.3         | 88.6         | $^{\circ}\text{C}/\text{W}$ |
| $R_{\theta JC(top)}$          | Junction-to-case (top) thermal resistance    | 56.3                       | 31.2        | 65.4         | 46.13        | $^{\circ}\text{C}/\text{W}$ |
| $R_{\theta JB}$               | Junction-to-board thermal resistance         | 63.4                       | 71.7        | 62.1         | 49.12        | $^{\circ}\text{C}/\text{W}$ |
| $\psi_{JT}$                   | Junction-to-top characterization parameter   | 8.8                        | 0.6         | 31.3         | 14.17        | $^{\circ}\text{C}/\text{W}$ |
| $\psi_{JB}$                   | Junction-to-board characterization parameter | 62.6                       | 70.5        | 60.4         | 48.6         | $^{\circ}\text{C}/\text{W}$ |

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 6.5 Thermal Information, SNx5HVD3082E

| THERMAL METRIC <sup>(1)</sup> |                                              | SN65HVD3082E, SN75HVD3082E |             | SN65HVD3082E | UNIT                        |
|-------------------------------|----------------------------------------------|----------------------------|-------------|--------------|-----------------------------|
|                               |                                              | D (SOIC)                   | DGK (VSSOP) | P (PDIP)     |                             |
|                               |                                              | 8 PINS                     | 8 PINS      | 8 PINS       |                             |
| $R_{\theta JA}$               | Junction-to-ambient thermal resistance       | 114.4                      | 142.2       | 88.1         | $^{\circ}\text{C}/\text{W}$ |
| $R_{\theta JC(top)}$          | Junction-to-case (top) thermal resistance    | 55.1                       | 35.8        | 65.9         | $^{\circ}\text{C}/\text{W}$ |
| $R_{\theta JB}$               | Junction-to-board thermal resistance         | 61.6                       | 75.6        | 69.0         | $^{\circ}\text{C}/\text{W}$ |
| $\psi_{JT}$                   | Junction-to-top characterization parameter   | 8.8                        | 0.8         | 35.2         | $^{\circ}\text{C}/\text{W}$ |
| $\psi_{JB}$                   | Junction-to-board characterization parameter | 60.8                       | 74.8        | 64.3         | $^{\circ}\text{C}/\text{W}$ |

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 6.6 Electrical Characteristics: Driver

over operating free-air temperature range (unless otherwise noted)

| PARAMETER            |                                                    | TEST CONDITIONS                                                                     | MIN  | TYP <sup>(1)</sup> | MAX | UNIT |
|----------------------|----------------------------------------------------|-------------------------------------------------------------------------------------|------|--------------------|-----|------|
| V <sub>OD</sub>      | Differential output voltage                        | I <sub>O</sub> = 0, No Load                                                         | 3    | 4.3                |     | V    |
|                      |                                                    | R <sub>L</sub> = 54 Ω (see 图 7-1)                                                   | 1.5  | 2.3                |     |      |
|                      |                                                    | R <sub>L</sub> = 100 Ω                                                              | 2    |                    |     |      |
|                      |                                                    | V <sub>TEST</sub> = –7 V to 12 V (see 图 7-2)                                        | 1.5  |                    |     |      |
| Δ V <sub>OD</sub>    | Change in magnitude of differential output voltage | See 图 7-1 and 图 7-2                                                                 | –0.2 | 0                  | 0.2 | V    |
| V <sub>OC(SS)</sub>  | Steady-state common-mode output voltage            | See 图 7-3                                                                           | 1    | 2.6                | 3   | V    |
| ΔV <sub>OC(SS)</sub> | Change in steady-state common-mode output voltage  |                                                                                     | –0.1 | 0                  | 0.1 |      |
| V <sub>OC(PP)</sub>  | Peak-to-peak common-mode output voltage            | See 图 7-3                                                                           | 500  |                    |     | mV   |
| I <sub>OZ</sub>      | High-impedance output current                      | See receiver input currents in <a href="#">Electrical Characteristics: Receiver</a> |      |                    |     |      |
| I <sub>I</sub>       | Input current                                      | D, DE                                                                               | –100 |                    | 100 | μA   |
| I <sub>OS</sub>      | Short-circuit output current                       | –7 V ≤ V <sub>O</sub> ≤ 12 V (see 图 7-7 )                                           | –250 |                    | 250 | mA   |

(1) All typical values are at 25°C and with a 5-V supply.

## 6.7 Electrical Characteristics: Receiver

over operating free-air temperature range (unless otherwise noted)

| PARAMETER         |                                                           | TEST CONDITIONS                                                           | MIN   | TYP <sup>(1)</sup> | MAX   | UNIT |
|-------------------|-----------------------------------------------------------|---------------------------------------------------------------------------|-------|--------------------|-------|------|
| V <sub>IT+</sub>  | Positive-going differential input threshold voltage       | I <sub>O</sub> = −8 mA                                                    |       | −85                | −10   | mV   |
| V <sub>IT−</sub>  | Negative-going differential input threshold voltage       | I <sub>O</sub> = 8 mA                                                     | −200  | −115               |       | mV   |
| V <sub>hys</sub>  | Hysteresis voltage (V <sub>IT+</sub> − V <sub>IT−</sub> ) |                                                                           |       | 30                 |       | mV   |
| V <sub>OH</sub>   | High-level output voltage                                 | V <sub>ID</sub> = 200 mV, I <sub>OH</sub> = −8 mA (see 图 7-8)             | 4     | 4.6                |       | V    |
| V <sub>OL</sub>   | Low-level output voltage                                  | V <sub>ID</sub> = −200 mV, I <sub>O</sub> = 8 mA (see 图 7-8)              |       | 0.15               | 0.4   | V    |
| I <sub>OZ</sub>   | High-impedance-state output current                       | V <sub>O</sub> = 0 or V <sub>CC</sub> , $\overline{RE}$ = V <sub>CC</sub> | −1    |                    | 1     | μA   |
| I <sub>I</sub>    | Bus input current                                         | V <sub>IH</sub> = 12 V, V <sub>CC</sub> = 5 V                             |       | 0.04               | 0.1   | mA   |
|                   |                                                           | V <sub>IH</sub> = 12 V, V <sub>CC</sub> = 0 V                             |       | 0.06               | 0.125 |      |
|                   |                                                           | V <sub>IH</sub> = −7 V, V <sub>CC</sub> = 5 V                             | −0.1  | −0.04              |       |      |
|                   |                                                           | V <sub>IH</sub> = −7 V, V <sub>CC</sub> = 0 V                             | −0.05 | −0.03              |       |      |
| I <sub>IH</sub>   | High-level input current, ( $\overline{RE}$ )             | V <sub>IH</sub> = 2 V                                                     | −60   | −30                |       | μA   |
| I <sub>IL</sub>   | Low-level input current, ( $\overline{RE}$ )              | V <sub>IL</sub> = 0.8 V                                                   | −60   | −30                |       | μA   |
| C <sub>diff</sub> | Differential input capacitance                            | V <sub>I</sub> = 0.4 sin (4E6πt) + 0.5 V, DE at 0 V                       |       | 7                  |       | pF   |

(1) All typical values are at 25°C and with a 5-V supply.

## 6.8 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

| PARAMETER          |                                   | TEST CONDITIONS                                                                                                                                  | MIN          | TYP <sup>(1)</sup> | MAX | UNIT |
|--------------------|-----------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------|--------------|--------------------|-----|------|
| I <sub>CC</sub>    | Driver and receiver enabled       | D at V <sub>CC</sub> or open, DE at V <sub>CC</sub> ,<br>RE at 0 V, No load                                                                      |              | 425                | 900 | μA   |
|                    | Driver enabled, receiver disabled | D at V <sub>CC</sub> or open, DE at V <sub>CC</sub> ,<br>RE at V <sub>CC</sub> , No load                                                         |              | 330                | 600 | μA   |
|                    | Receiver enabled, driver disabled | D at V <sub>CC</sub> or open, DE at 0 V,<br>RE at 0 V, No load                                                                                   |              | 300                | 600 | μA   |
|                    | Driver and receiver disabled      | D at V <sub>CC</sub> or open, DE at 0 V,<br>RE at V <sub>CC</sub>                                                                                |              | 0.001              | 2   | μA   |
| P <sub>(AVG)</sub> | Average power dissipation         | Input to D is a 50% duty cycle square wave at max specified signal rate<br>R <sub>L</sub> = 54 Ω V <sub>CC</sub> = 5.5 V, T <sub>J</sub> = 130°C | ALL HVD3082E |                    | 203 | mW   |
|                    |                                   |                                                                                                                                                  | ALL HVD3085E |                    | 205 |      |
|                    |                                   |                                                                                                                                                  | ALL HVD3088E |                    | 276 |      |

(1) All typical values are at 25°C and with a 5-V supply.

## 6.9 Switching Characteristics: Driver

over operating free-air temperature range (unless otherwise noted)

| PARAMETER                                        |                                                                                                                           | TEST CONDITIONS                                                                                 |          | MIN | TYP  | MAX  | UNIT |
|--------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------|----------|-----|------|------|------|
| t <sub>PLH</sub><br>t <sub>PHL</sub>             | Propagation delay time, low-to-high-level output<br>Propagation delay time, high-to-low-level output                      | R <sub>L</sub> = 54 Ω, C <sub>L</sub> = 50 pF<br>(see <a href="#">Fig 7-4</a> )                 | HVD3082E |     | 700  | 1300 | ns   |
|                                                  |                                                                                                                           |                                                                                                 | HVD3085E |     | 150  | 500  |      |
|                                                  |                                                                                                                           |                                                                                                 | HVD3088E |     | 12   | 20   |      |
| t <sub>r</sub><br>t <sub>f</sub>                 | Differential output signal rise time<br>Differential output signal fall time                                              | R <sub>L</sub> = 54 Ω, C <sub>L</sub> = 50 pF<br>(see <a href="#">Fig 7-4</a> )                 | HVD3082E | 500 | 900  | 1500 | ns   |
|                                                  |                                                                                                                           |                                                                                                 | HVD3085E |     | 200  | 300  |      |
|                                                  |                                                                                                                           |                                                                                                 | HVD3088E |     | 7    | 15   |      |
| t <sub>sk(p)</sub>                               | Pulse skew ( t <sub>PHL</sub> – t <sub>PLH</sub>  )                                                                       | R <sub>L</sub> = 54 Ω, C <sub>L</sub> = 50 pF<br>(see <a href="#">Fig 7-4</a> )                 | HVD3082E |     | 20   | 200  | ns   |
|                                                  |                                                                                                                           |                                                                                                 | HVD3085E |     | 5    | 50   |      |
|                                                  |                                                                                                                           |                                                                                                 | HVD3088E |     | 1.4  | 2    |      |
| t <sub>PZH</sub><br>t <sub>PZL</sub>             | Propagation delay time, high-impedance-to-high-level output<br>Propagation delay time, high-impedance-to-low-level output | R <sub>L</sub> = 110 Ω, RE at 0 V<br>(see <a href="#">Fig 7-5</a> and <a href="#">Fig 7-6</a> ) | HVD3082E |     | 2500 | 7000 | ns   |
|                                                  |                                                                                                                           |                                                                                                 | HVD3085E |     | 1000 | 2500 |      |
|                                                  |                                                                                                                           |                                                                                                 | HVD3088E |     | 13   | 30   |      |
| t <sub>PHZ</sub><br>t <sub>PLZ</sub>             | Propagation delay time, high-level-to-high-impedance output<br>Propagation delay time, low-level-to-high-impedance output | R <sub>L</sub> = 110 Ω, RE at 0 V<br>(see <a href="#">Fig 7-5</a> and <a href="#">Fig 7-6</a> ) | HVD3082E |     | 80   | 200  | ns   |
|                                                  |                                                                                                                           |                                                                                                 | HVD3085E |     | 60   | 100  |      |
|                                                  |                                                                                                                           |                                                                                                 | HVD3088E |     | 12   | 30   |      |
| t <sub>PZH(SHDN)</sub><br>t <sub>PZL(SHDN)</sub> | Propagation delay time, shutdown-to-high-level output<br>Propagation delay time, shutdown-to-low-level output             | R <sub>L</sub> = 110 Ω, RE at V <sub>CC</sub><br>(see <a href="#">Fig 7-5</a> )                 | HVD3082E |     | 3500 | 7000 | ns   |
|                                                  |                                                                                                                           |                                                                                                 | HVD3085E |     | 2500 | 4500 |      |
|                                                  |                                                                                                                           |                                                                                                 | HVD3088E |     | 1600 | 2600 |      |

## 6.10 Switching Characteristics

over operating free-air temperature range (unless otherwise noted)

| PARAMETER       |                                                       | TEST CONDITIONS                                                                                       |                      | MIN | TYP  | MAX  | UNIT |
|-----------------|-------------------------------------------------------|-------------------------------------------------------------------------------------------------------|----------------------|-----|------|------|------|
| $t_{PLH}$       | Propagation delay time, low-to-high-level output      | $C_L = 15 \text{ pF}$ (see <a href="#">Fig 7-9</a> )                                                  | HVD3082E<br>HVD3085E |     | 75   | 200  | ns   |
|                 |                                                       |                                                                                                       | HVD3088E             |     |      | 100  |      |
| $t_{PHL}$       | Propagation delay time, high-to-low-level output      |                                                                                                       | HVD3082E<br>HVD3085E |     | 79   | 200  | ns   |
|                 |                                                       |                                                                                                       | HVD3088E             |     |      | 100  |      |
| $t_{sk(p)}$     | Pulse skew ( $ t_{PHL} - t_{PLH} $ )                  |                                                                                                       | HVD3082E<br>HVD3085E |     | 4    | 30   | ns   |
|                 |                                                       |                                                                                                       | HVD3088E             |     |      | 10   |      |
| $t_r$           | Output signal rise time                               | $V_{ID} = -1.5 \text{ V to } 1.5 \text{ V}$ ,<br>$C_L = 15 \text{ pF}$ (see <a href="#">Fig 7-9</a> ) |                      |     | 1.5  | 3    | ns   |
| $t_f$           | Output signal fall time                               |                                                                                                       |                      |     | 1.8  | 3    |      |
| $t_{PZH}$       | Output enable time to high level                      | $C_L = 15 \text{ pF}$ ,<br>DE at 3 V<br>(see <a href="#">Fig 7-10</a> and <a href="#">Fig 7-11</a> )  | HVD3082E<br>HVD3085E |     | 5    | 50   | ns   |
|                 |                                                       |                                                                                                       | HVD3088E             |     |      | 30   |      |
| $t_{PZL}$       | Output enable time to low level                       |                                                                                                       | HVD3082E<br>HVD3085E |     | 10   | 50   | ns   |
|                 |                                                       |                                                                                                       | HVD3088E             |     |      | 30   |      |
| $t_{PHZ}$       | Output enable time from high level                    |                                                                                                       | HVD3082E<br>HVD3085E |     | 5    | 50   | ns   |
|                 |                                                       |                                                                                                       | HVD3088E             |     |      | 30   |      |
| $t_{PLZ}$       | Output disable time from low level                    |                                                                                                       | HVD3082E<br>HVD3085E |     | 8    | 50   | ns   |
|                 |                                                       |                                                                                                       | HVD3088E             |     |      | 30   |      |
| $t_{PZH(SHDN)}$ | Propagation delay time, shutdown-to-high-level output | $C_L = 15 \text{ pF}$ , DE at 0 V,<br>(see <a href="#">Fig 7-12</a> )                                 |                      |     | 1600 | 3500 | ns   |
| $t_{PZL(SHDN)}$ | Propagation delay time, shutdown-to-low-level output  |                                                                                                       |                      |     | 1700 | 3500 |      |

## 6.11 Typical Characteristics

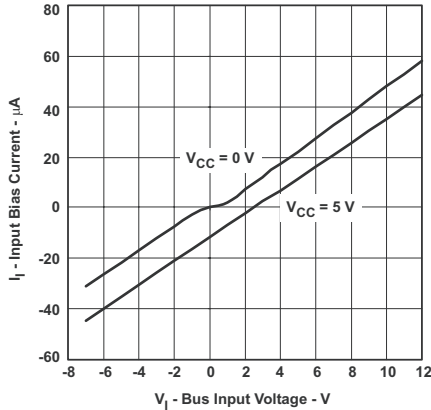


图 6-1. Bus Input Current versus Bus Input Voltage

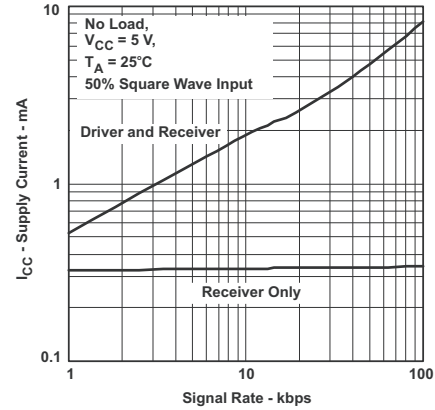


图 6-2. SN65HVD3082E RMS Supply Current versus Signaling Rate

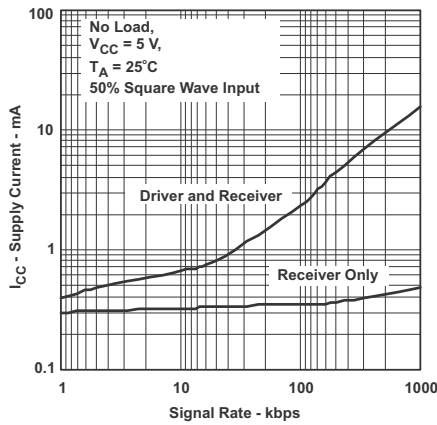


图 6-3. SN65HVD3085E RMS Supply Current versus Signaling Rate

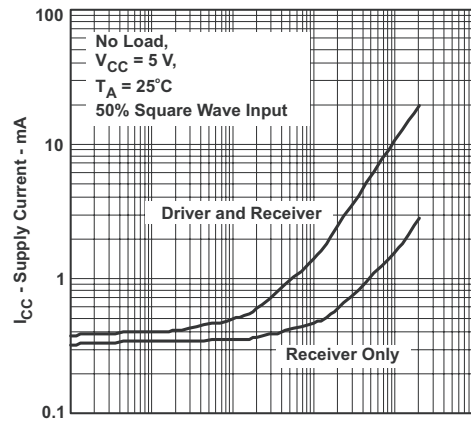


图 6-4. SN65HVD3088E RMS Supply Current versus Signal Rate

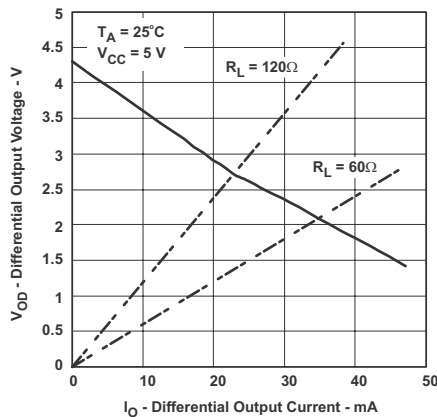


图 6-5. Driver Differential Output Voltage versus Driver Output Current

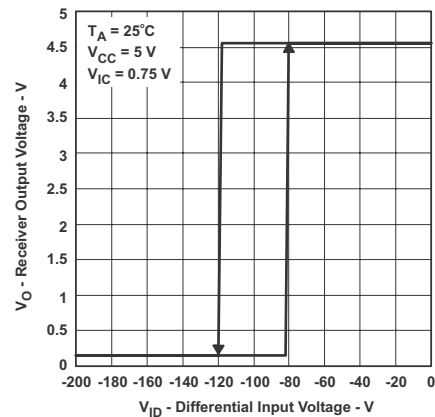


图 6-6. Receiver Output Voltage versus Differential Input Voltage

## 6.11 Typical Characteristics (continued)

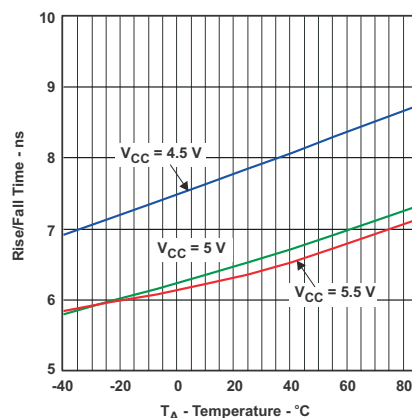


图 6-7. SN65HVD3088E Driver Rise and Fall Time versus Temperature

## 7 Parameter Measurement Information

Test load capacitance includes probe and jig capacitance (unless otherwise specified). Signal generator characteristics: rise and fall time < 6 ns, pulse rate 100 kHz, 50% duty cycle.  $Z_O = 50\ \Omega$  (unless otherwise specified).

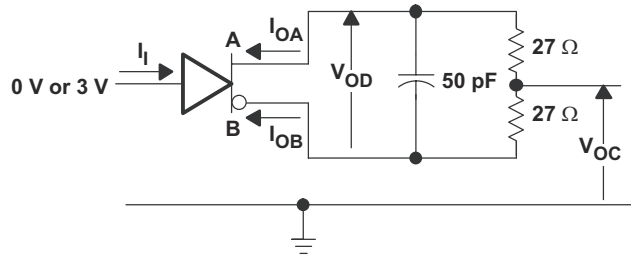


图 7-1. Driver Test Circuit,  $V_{OD}$  and  $V_{OC}$  Without Common-Mode Loading

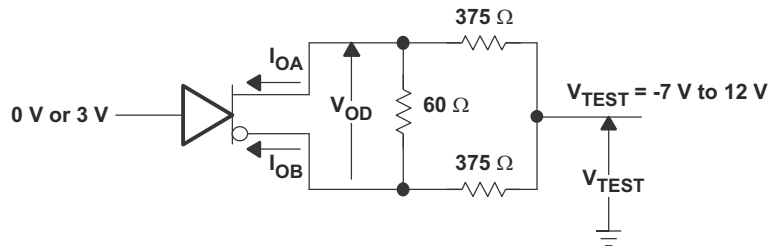


图 7-2. Driver Test Circuit,  $V_{OD}$  With Common-Mode Loading

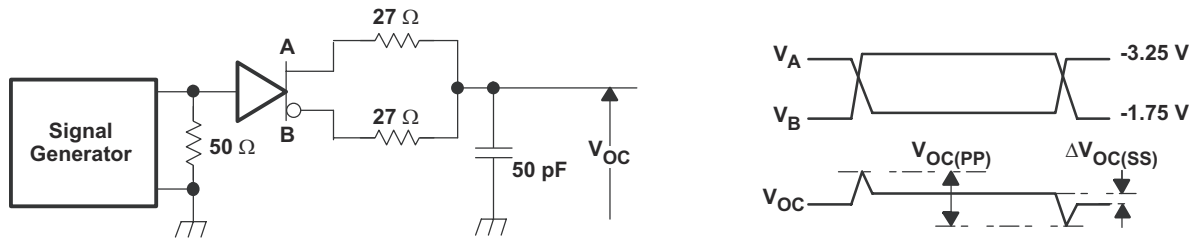


图 7-3. Driver  $V_{OC}$  Test Circuit and Waveforms

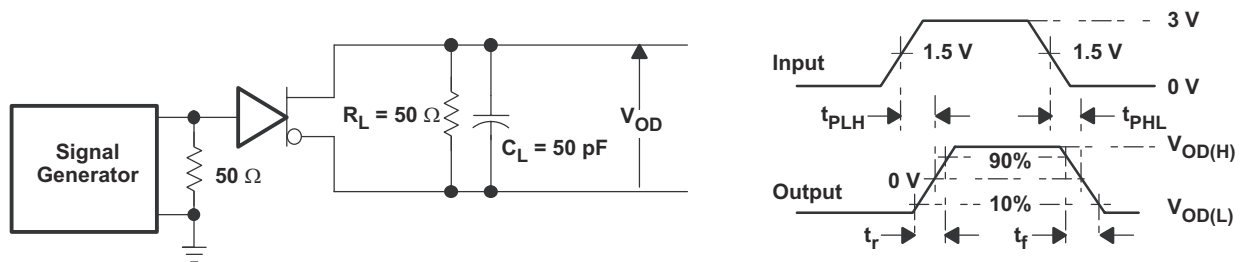


图 7-4. Driver Switching Test Circuit and Waveforms

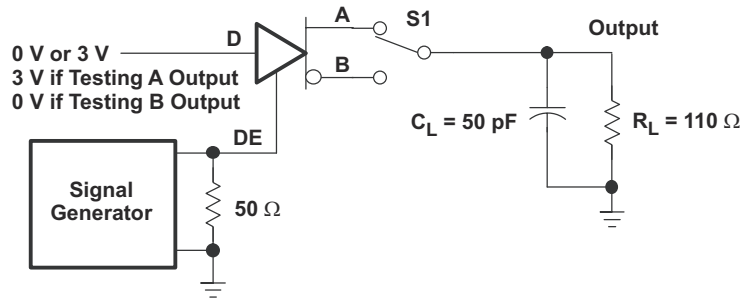


图 7-5. Driver Enable and Disable Test Circuit and Waveforms, High Output

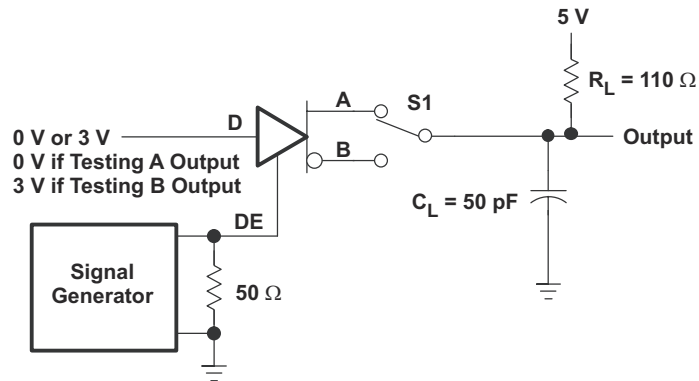


图 7-6. Driver Enable and Disable Test Circuit and Waveforms, Low Output

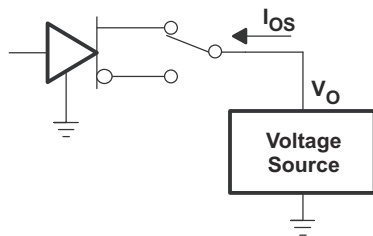


图 7-7. Driver Short-Circuit

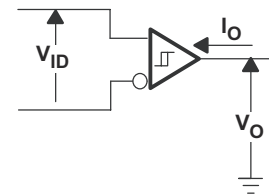


图 7-8. Receiver Switching Test Circuit and Waveforms

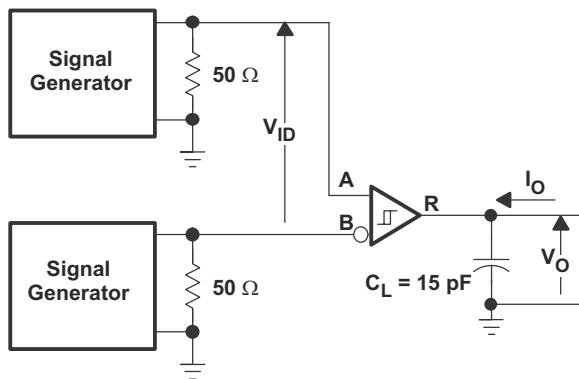


图 7-9. Receiver Switching Test Circuit and Waveforms

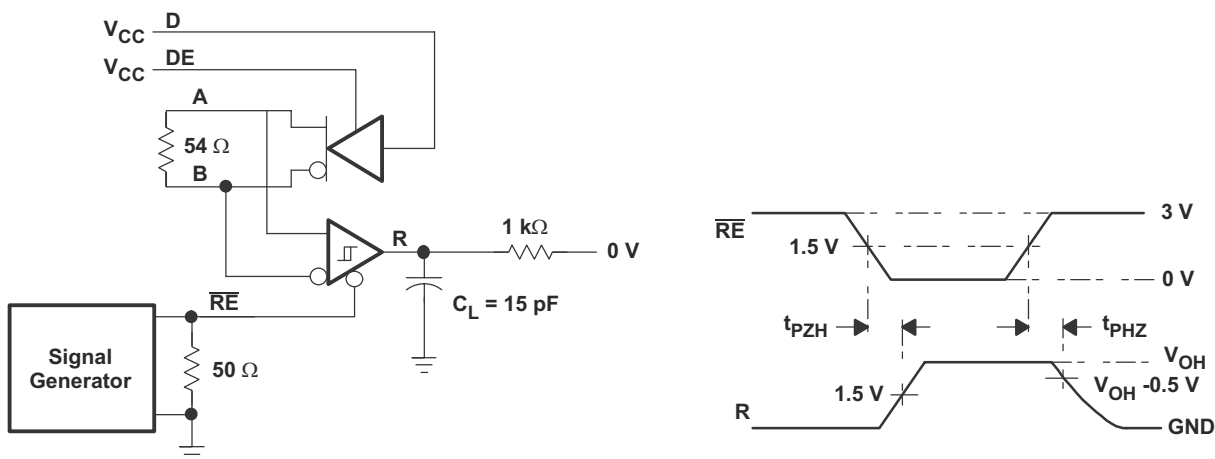


图 7-10. Receiver Enable and Disable Test Circuit and Waveforms, Data Output High

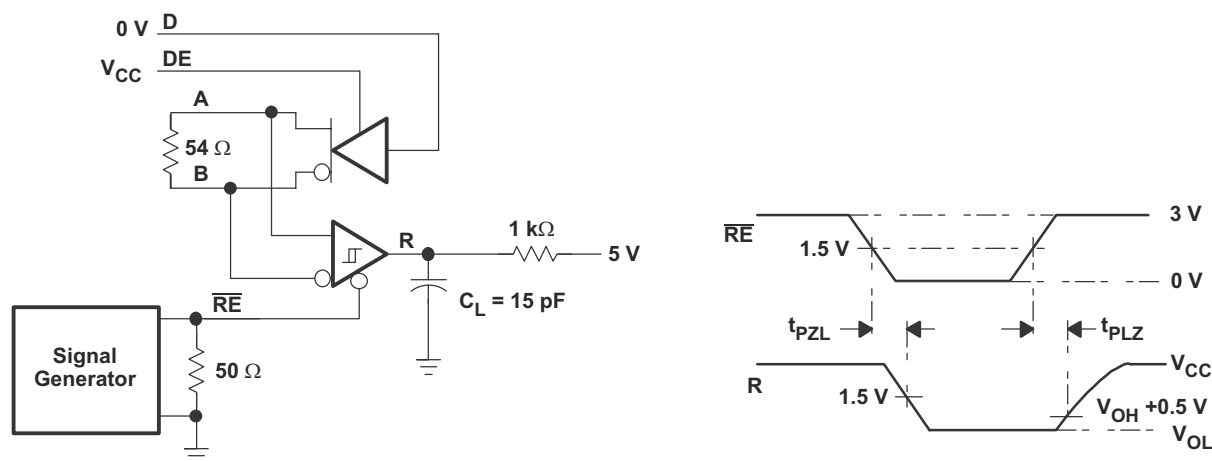


图 7-11. Receiver Enable and Disable Test Circuit and Waveforms, Data Output Low

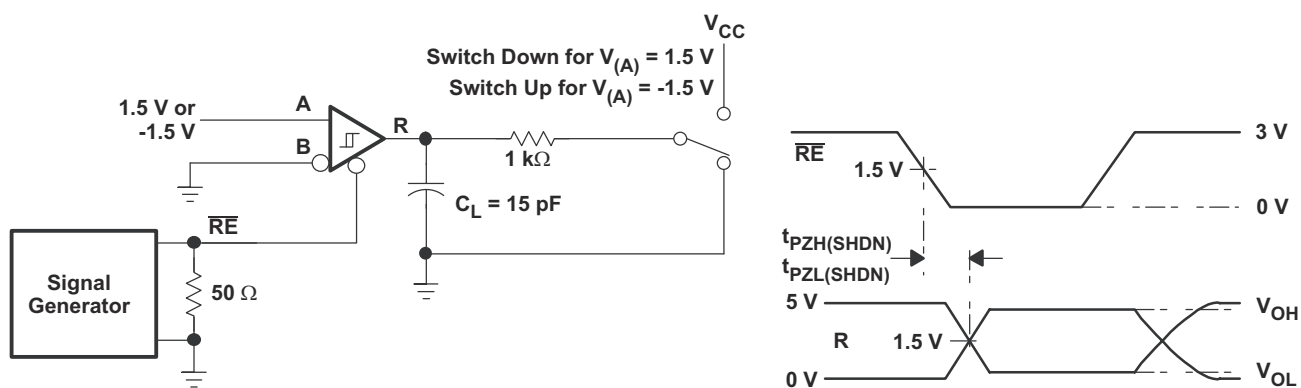


图 7-12. Receiver Enable From Shutdown Test Circuit and Waveforms

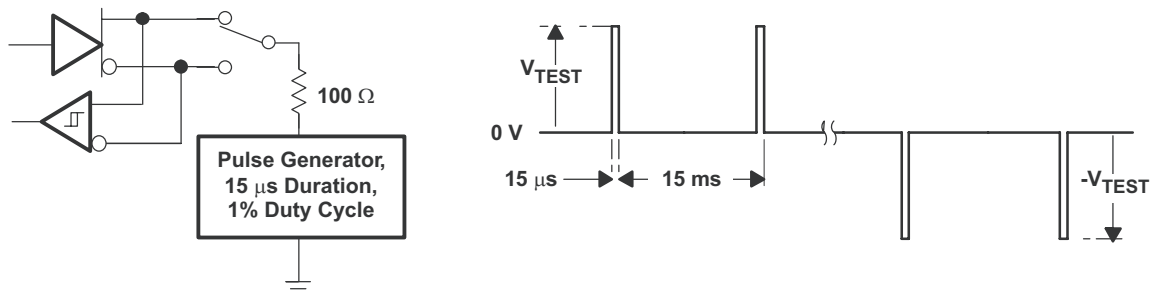


图 7-13. Test Circuit and Waveforms, Transient Overvoltage Test

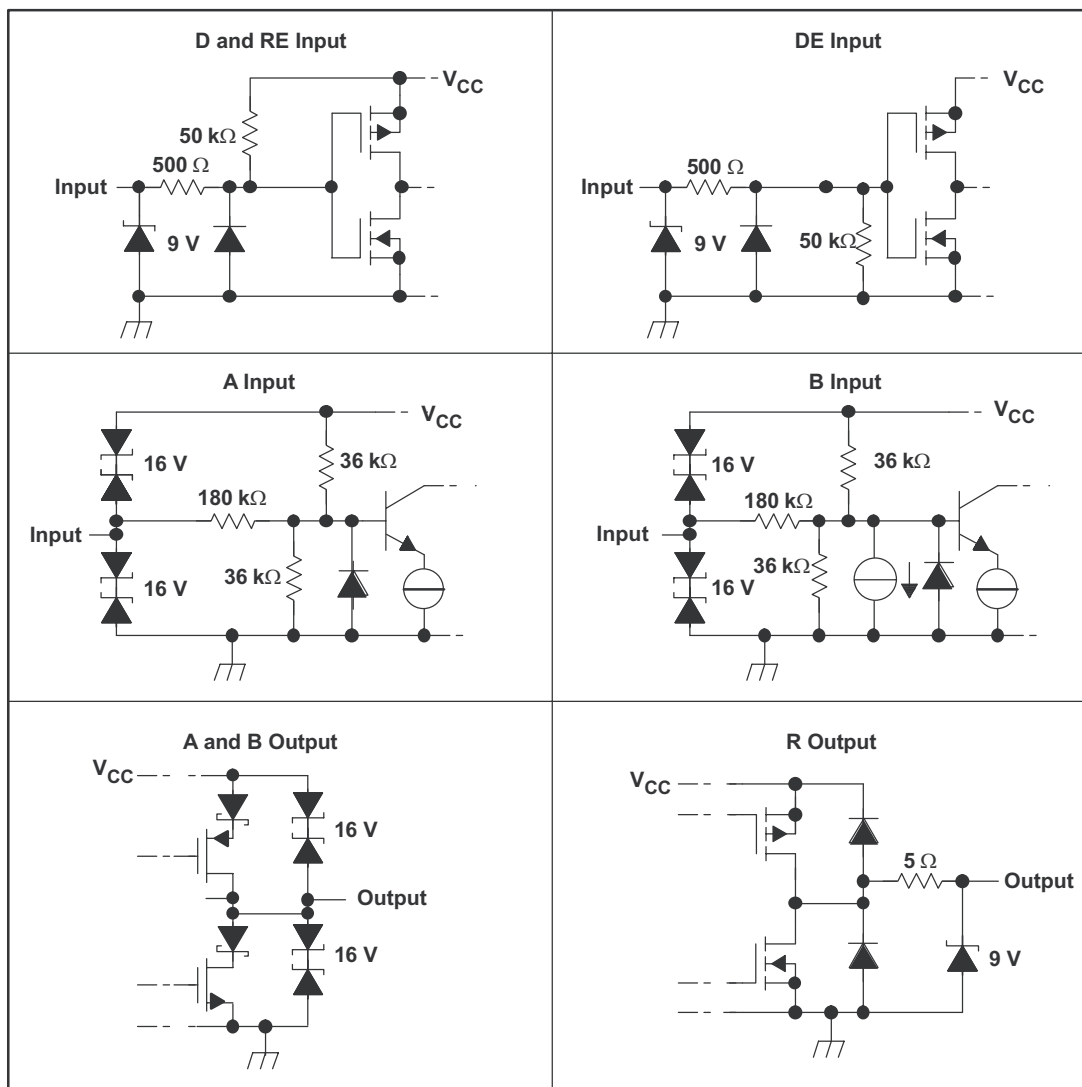


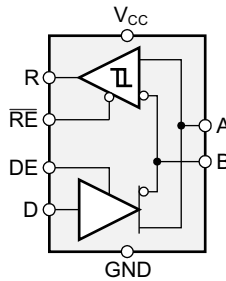
图 7-14. Equivalent Input and Output Schematic Diagrams

## 8 Detailed Description

### 8.1 Overview

The SNx5HVD308xE family of half-duplex RS-485 transceivers is suitable for data transmission at rates up to 200 kbps (for SN65HVD3082E and SN75HVD3082E), 1 Mbps (for SN65HVD3085E), or 20 Mbps (for SN65HVD3088E) over controlled-impedance transmission media (such as twisted-pair cabling). Up to 256 units of SNx5HVD308xE may share a common RS-485 bus due to the family's low bus input currents. The devices also feature a high degree of ESD protection and typical standby current consumption of 1 nA.

### 8.2 Functional Block Diagram



### 8.3 Feature Description

The SNx5HVD308xE provides internal biasing of the receiver input thresholds for open-circuit, bus-idle, or short-circuit fail-safe conditions. It features a typical hysteresis of 30 mV in order to improve noise immunity. Internal ESD protection circuits protect the transceiver bus terminals against  $\pm 15$ -kV Human Body Model (HBM) electrostatic discharges.

The devices protect themselves against damage due to overtemperature conditions, through the use of a thermal shutdown feature. Thermal shutdown is entered at 165°C (nominal) and causes the device to enter a low-power state with high-impedance outputs.

### 8.4 Device Functional Modes

When the driver enable pin, DE, is logic high, the differential outputs A and B follow the logic states at data input D. A logic high at D causes A to turn high and B to turn low. In this case the differential output voltage defined as  $V_{OD} = V_A - V_B$  is positive. When D is low, the output states reverse, B turns high, A becomes low, and  $V_{OD}$  is negative.

When DE is low, both outputs turn high-impedance. In this condition the logic state at D is irrelevant. The DE pin has an internal pull-down resistor to ground, thus when left open the driver is disabled (high-impedance) by default. The D pin has an internal pull-up resistor to  $V_{CC}$ , thus, when left open while the driver is enabled, output A turns high and B turns low.

**表 8-1. Driver Function Table**

| INPUT | ENABLE <sup>(1)</sup> | OUTPUTS <sup>(1)</sup> |   | FUNCTION                           |
|-------|-----------------------|------------------------|---|------------------------------------|
| D     | DE                    | A                      | B |                                    |
| H     | H                     | H                      | L | Actively drive bus High            |
| L     | H                     | L                      | H | Actively drive bus Low             |
| X     | L                     | Z                      | Z | Driver disabled                    |
| X     | OPEN                  | Z                      | Z | Driver disabled by default         |
| OPEN  | H                     | H                      | L | Actively drive bus High by default |

(1) H = high level, L = low level, Z = high impedance, X = irrelevant

When the receiver enable pin,  $\overline{RE}$ , is logic low, the receiver is enabled. When the differential input voltage defined as  $V_{ID} = V_A - V_B$  is positive and higher than the positive input threshold,  $V_{IT+}$ , the receiver output, R, turns high. When  $V_{ID}$  is negative and lower than the negative input threshold,  $V_{IT-}$ , the receiver output, R, turns low. If  $V_{ID}$  is between  $V_{IT+}$  and  $V_{IT-}$  the output is indeterminate.

When  $\overline{RE}$  is logic high or left open, the receiver output is high-impedance and the magnitude and polarity of  $V_{ID}$  are irrelevant. Internal biasing of the receiver inputs causes the output to go failsafe-high when the transceiver is disconnected from the bus (open-circuit), the bus lines are shorted (short-circuit), or the bus is not actively driven (idle bus).

表 8-2. Receiver Function Table

| DIFFERENTIAL INPUT           | ENABLE <sup>(1)</sup> | OUTPUT <sup>(1)</sup> | FUNCTION                     |
|------------------------------|-----------------------|-----------------------|------------------------------|
| $V_{ID} = V_A - V_B$         | $\overline{RE}$       | R                     |                              |
| $V_{IT+} < V_{ID}$           | L                     | H                     | Receive valid bus High       |
| $V_{IT-} < V_{ID} < V_{IT+}$ | L                     | ?                     | Indeterminate bus state      |
| $V_{ID} < V_{IT-}$           | L                     | L                     | Receive valid bus Low        |
| X                            | H                     | Z                     | Receiver disabled            |
| X                            | OPEN                  | Z                     | Receiver disabled by default |
| Open-circuit bus             | L                     | H                     | Fail-safe high output        |
| Short-circuit bus            | L                     | H                     | Fail-safe high output        |
| Idle (terminated) bus        | L                     | H                     | Fail-safe high output        |

(1) H = high level, L = low level, Z = high impedance, X = irrelevant, ? = indeterminate

## 9 Application and Implementation

### 备注

以下应用部分中的信息不属于 TI 器件规格的范围，TI 不担保其准确性和完整性。TI 的客户应负责确定器件是否适用于其应用。客户应验证并测试其设计，以确保系统功能。

### 9.1 Application Information

The SNx5HVD308xE devices are half-duplex RS-485 transceivers commonly used for asynchronous data transmissions. The driver and receiver enable pins allow the configuration of different operating modes.

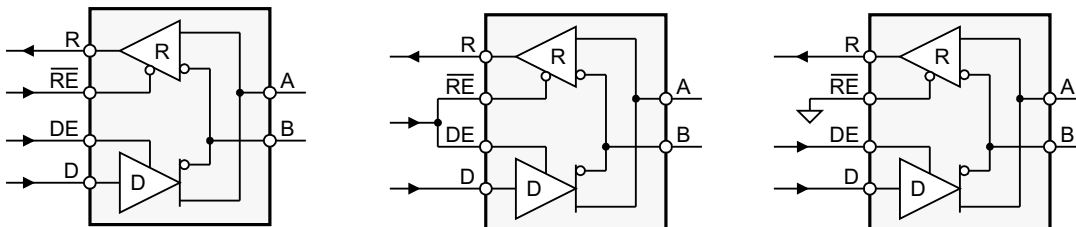


图 9-1. Half-Duplex Transceiver Configurations

Using independent enable lines provides the most flexible control, as it allows the driver and the receiver to be turned on and off individually. While this configuration requires two control lines, it allows selective listening into the bus traffic whether the driver is transmitting data or not.

Combining the enable signals simplify the interface to the controller, by forming a single direction-control signal. In this configuration, the transceiver operates as a driver when the direction-control line is high and as a receiver when the direction-control line is low.

Additionally, only one line is required when connecting the receiver-enable input to ground and controlling only the driver-enable input. In this configuration, a node not only receives the data from the bus, but also the data it sends and can verify that the correct data has been transmitted.

### 9.2 Typical Application

An RS-485 bus consists of multiple transceivers connecting in parallel to a bus cable. To eliminate line reflections, each cable end is terminated with a termination resistor,  $R_T$ , whose value matches the characteristic impedance,  $Z_0$ , of the cable. This method, known as parallel termination, allows higher data rates over longer cable length.

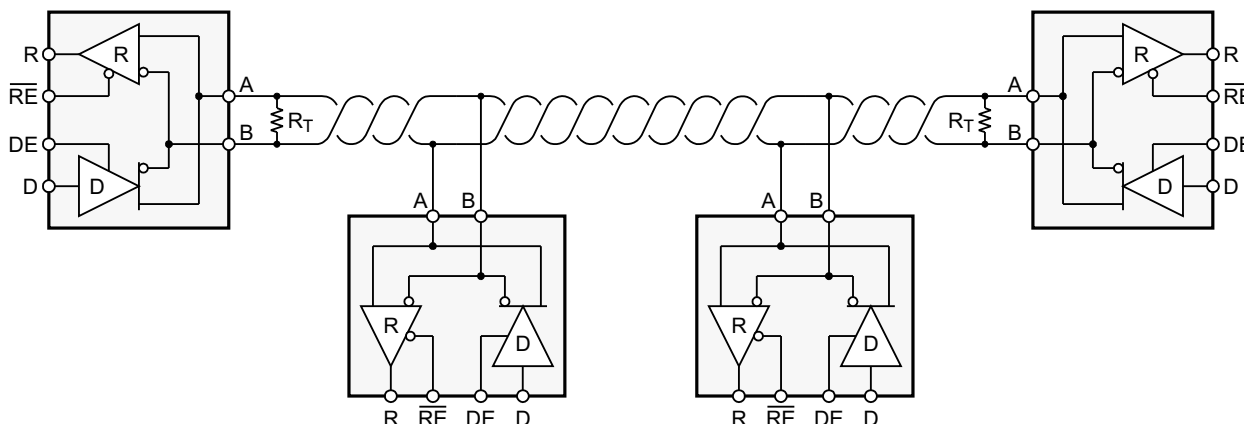


图 9-2. Typical Application Circuit

## 9.2.1 Design Requirements

RS-485 is a robust electrical standard suitable for long-distance networking that may be used in a wide range of applications with varying requirements, such as distance, data rate, and number of nodes.

### 9.2.1.1 Data Rate and Bus Length

The inverse relationship between the data rate and bus length, means the higher the data rate, the shorter the cable length; and conversely, the lower the data rate, the longer the cable can be without introducing data errors. While most RS-485 systems use data rates between 10 kbps and 100 kbps, some applications require data rates up to 250 kbps at distances of 4,000 feet and longer. The longer distances can be achieved by allowing small signal jitter of up to 5 or 10%.

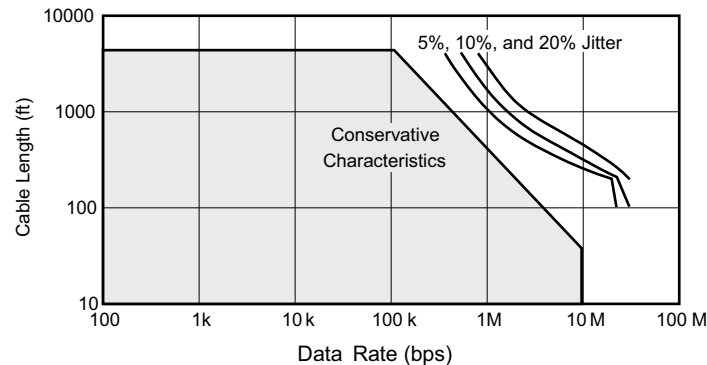


图 9-3. Cable Length vs Data Rate Characteristic

### 9.2.1.2 Stub Length

The distance between the transceiver inputs and the cable trunk, which is known as the **stub**, must be short as possible when connecting a node to the bus. Stubs present a non-terminated piece of bus line which can introduce reflections as the length of the stub increases. As a general guideline, the electrical length, or round-trip delay of a stub, must be less than one-tenth of the rise time of the driver, thus giving a maximum physical stub length as shown in 方程式 1.

$$L_{\text{stub}} \leq 0.1 \times t_r \times v \times c \quad (1)$$

where:

- $t_r$  is the 10/90 rise time of the driver
- $c$  is the speed of light ( $3 \times 10^8$  m/s)
- $v$  is the signal velocity of the cable or trace as a factor of  $c$

### 9.2.1.3 Bus Loading

The RS-485 standard specifies that a compliant driver must be able to driver 32 unit loads (UL), where 1 unit load represents a load impedance of approximately 12 kΩ. The SNx5HVD308xE is a 1/8 UL transceiver, which means it can connect up to 256 receivers to the bus.

### 9.2.1.4 Receiver Fail-safe

The differential receiver is fail-safe to invalid bus states caused by:

- Open bus conditions, such as a disconnected connector
- Shorted bus conditions, such as cable damage shorting the twisted-pair together
- Idle bus conditions that occur when no driver on the bus is actively driving

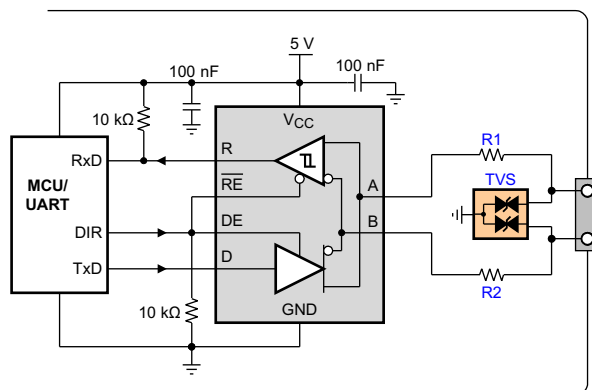
In any of these cases, the differential receiver outputs a fail-safe logic High state, so that the output of the receiver is not indeterminate.

Receiver fail-safe is accomplished by offsetting the receiver thresholds, so that the *input indeterminate* range does not include zero volts differential. To comply with the RS-422 and RS-485 standards, the receiver output must output a High when the differential input  $V_{ID}$  is more positive than +200 mV, and must output a Low when the  $V_{ID}$  is more negative than –200 mV. The receiver parameters which determine the fail-safe performance are  $V_{IT+}$  and  $V_{IT-}$  and  $V_{HYS}$ . As seen in the [Electrical Characteristics](#) table, differential signals more negative than –200 mV will always cause a Low receiver output and differential signals more positive than +200 mV will always cause a High receiver output.

When the differential input signal is close to zero, it is still above the maximum  $V_{IT+}$  threshold, and the receiver output is High. Only when the differential input is more negative than  $V_{IT-}$  will the receiver output transition to a Low state. The noise immunity of the receiver inputs during a bus fault condition, includes the receiver hysteresis value  $V_{HYS}$  (the separation between  $V_{IT+}$  and  $V_{IT-}$ ) as well as the value of  $V_{IT+}$ .

### 9.2.2 Detailed Design Procedure

In order to protect bus nodes against high-energy transients, the implementation of external transient protection devices is necessary.



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**图 9-4. Transient Protection Against ESD, EFT, and Surge Transients**

图 9-4 suggests a protection circuit against 10-kV ESD (IEC 61000-4-2), 4-kV EFT (IEC 61000-4-4), and 1-kV surge (IEC 61000-4-5) transients. 表 9-1 shows the associated Bill of Materials.

**表 9-1. Bill of Materials**

| DEVICE | FUNCTION                                 | ORDER NUMBER      | MANUFACTURER |
|--------|------------------------------------------|-------------------|--------------|
| XCVR   | RS-485 Transceiver                       | SNx5HVD308xE      | TI           |
| R1, R2 | 10-Ω, Pulse-Proof Thick-Film Resistor    | CRCW060310RJNEAHP | Vishay       |
| TVS    | Bidirectional 400-W Transient Suppressor | CDSOT23-SM712     | Bourns       |

### 9.2.2.1 Power Usage in an RS-485 Transceiver

With power consumption being a concern in many applications, power supply current is delivered to the bus load as well as to the transceiver circuitry. For a typical RS-485 bus configuration, the load that an active driver must drive consists of all of the receiving nodes, plus the termination resistors at each end of the bus.

The load presented by the receiving nodes depends on the input impedance of the receiver. The TIA/EIA-485A standard defines a unit load as allowing up to 1 mA. With up to 32 unit loads allowed on the bus, the total current supplied to all receivers can be as high as 32 mA. The HVD308xE is rated as a 1/8 unit load device. As shown in [图 6-1](#), the bus input current is less than 0.125 mA, allowing up to 256 nodes on a single bus.

The current in the termination resistors depends on the differential bus voltage. The standard requires active drivers to produce at least 1.5 V of differential signal. For a bus terminated with one standard 120-Ω resistor at each end, this sums to 25 mA differential output current whenever the bus is active. Typically, the HVD308xE can drive more than 25-mA to a 60-Ω load, resulting in a differential output voltage higher than the minimum required by the standard (see [图 6-3](#)).

Overall, the total load current can be 60 mA to a loaded RS-485 bus. This is in addition to the current required by the transceiver itself; the HVD308xE circuitry requires only about 0.4 mA with both driver and receiver enabled, and only 0.3 mA with either the driver enabled or with the receiver enabled. In low-power shutdown mode, neither the driver nor receiver is active, and the supply current is low.

Supply current increases with signaling rate primarily due to the totem pole outputs of the driver (see [图 6-2](#)). When these outputs change state, there is a moment when both the high-side and low-side output transistors are conducting and this creates a short spike in the supply current. As the frequency of state changes increases, more power is used.

### 9.2.2.2 Low-Power Shutdown Mode

When both the driver and receiver are disabled (DE low and  $\overline{\text{RE}}$  high) the device is in shutdown mode. If the enable inputs are in this state for less than 60 ns, the device does not enter shutdown mode. This guards against inadvertently entering shutdown mode during driver or receiver enabling. Only when the enable inputs are held in this state for 300 ns or more, the device is assured to be in shutdown mode. In this low-power shutdown mode, most internal circuitry is powered down, and the supply current is typically 1 nA. When either the driver or the receiver is re-enabled, the internal circuitry becomes active.

If only the driver is re-enabled (DE transitions to high) the driver outputs are driven according to the D input after the enable times given by  $t_{\text{PZH}}(\text{SHDN})$  and  $t_{\text{PZL}}(\text{SHDN})$  in the driver switching characteristics. If the D input is open when the driver is enabled, the driver outputs defaults to A high and B low, in accordance with the driver fail-safe feature.

If only the receiver is re-enabled (RE transitions to low) the receiver output is driven according to the state of the bus inputs (A and B) after the enable times given by  $t_{\text{PZH}}(\text{SHDN})$  and  $t_{\text{PZL}}(\text{SHDN})$  in the receiver switching characteristics. If there is no valid state on the bus the receiver responds as described in the fail-safe operation section.

If both the receiver and driver are re-enabled simultaneously, the receiver output is driven according to the state of the bus inputs (A and B) and the driver output is driven according to the D input.

---

#### 备注

The state of the active driver affects the inputs to the receiver. Therefore, the receiver outputs are valid as soon as the driver outputs are valid.

---

## 10 Power Supply Recommendations

To ensure reliable operation at all data rates and supply voltages, each supply must be decoupled with a 100-nF ceramic capacitor located as close to the supply pins as possible. This helps to reduce supply voltage ripple present on the outputs of switched-mode power supplies and also helps to compensate for the resistance and inductance of the PCB power planes.

## 11 Layout

### 11.1 Layout Guidelines

Robust and reliable bus node design often requires the use of external transient protection devices in order to protect against EFT and surge transients that may occur in industrial environments. Due to the wide frequency bandwidth (from approximately 3 MHz to 3 GHz) that the transients have, high-frequency layout techniques must be applied during PCB design.

- Place the protection circuitry close to the bus connector to prevent noise transients from entering the board.
- Use  $V_{CC}$  and ground planes to provide low-inductance.

#### 备注

High-frequency currents follow the path of least inductance and not the path of least impedance.

- Design the protection components into the direction of the signal path. Do not force the transients currents to divert from the signal path to reach the protection device.
- Apply 100-nF to 220-nF bypass capacitors as close as possible to the  $V_{CC}$  pins of transceiver, UART, and controller ICs on the board.
- Use at least two vias for  $V_{CC}$  and ground connections of bypass capacitors and protection devices to minimize effective via-inductance.
- Use 1-k $\Omega$  to 10-k $\Omega$  pullup or pulldown resistors for enable lines to limit noise currents in these lines during transient events.
- Insert series pulse-proof resistors into the A and B bus lines if the TVS clamping voltage is higher than the specified maximum voltage of the transceiver bus pins. These resistors limit the residual clamping current into the transceiver and prevent it from latching up.
- While pure TVS protection is sufficient for surge transients up to 1 kV, higher transients require metal-oxide varistors (MOVs) that reduce the transients to a few hundred volts of clamping voltage, and transient blocking units (TBUs) that limit transient current to 200 mA.

### 11.2 Layout Example

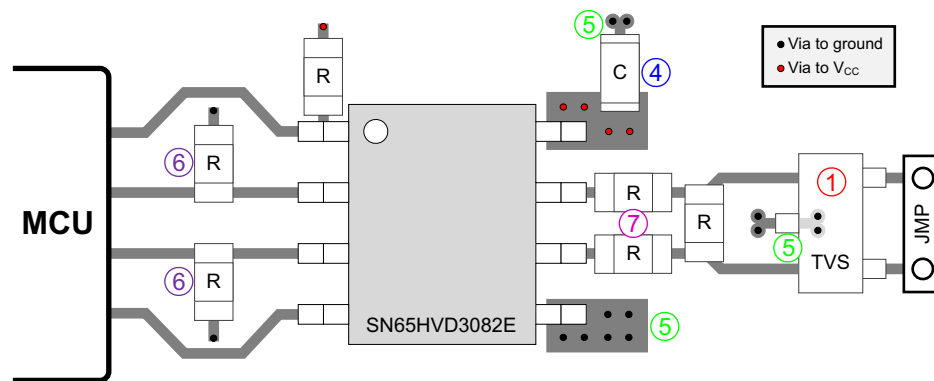


图 11-1. Layout Example

### 11.3 Thermal Considerations for IC Packages

$\theta_{JA}$  (Junction-to-Ambient Thermal Resistance) is defined as the difference in junction temperature to ambient temperature divided by the operating power.

$\theta_{JA}$  is **not** a constant and is a strong function of:

- the PCB design (50% variation)
- altitude (20% variation)
- device power (5% variation)

$\theta_{JA}$  can be used to compare the thermal performance of packages when the specific test conditions are defined and used. Standardized testing includes specification of PCB construction, test chamber volume, sensor locations, and the thermal characteristics of holding fixtures.  $\theta_{JA}$  is often misused when it is used to calculate junction temperatures for other installations.

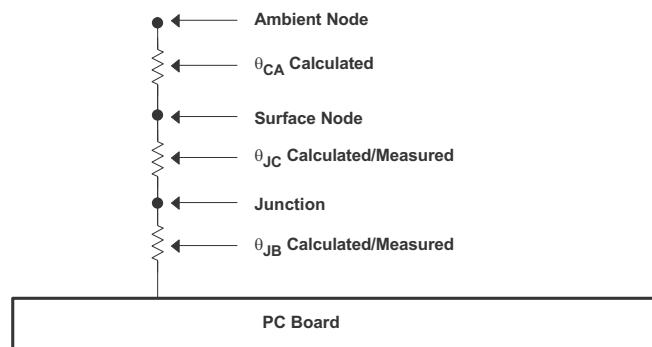
TI uses two test PCBs as defined by JEDEC specifications. The low-k board gives average in-use condition thermal performance and consists of a single trace layer 25-mm long and 2-oz thick copper. The high-k board gives best case in-use condition and consists of two 1-oz buried power planes with a single trace layer 25-mm long with 2-oz thick copper. A 4% to 50% difference in  $\theta_{JA}$  can be measured between these two test cards.

$\theta_{JC}$  (Junction-to-Case Thermal Resistance) is defined as the difference in junction temperature to case divided by the operating power. It is measured by putting the mounted package up against a copper block cold plate, to force heat to flow from the die through the mold compound and into the copper block.

$\theta_{JC}$  is a useful thermal characteristic when a heat sink is applied to package. It is NOT a useful characteristic to predict junction temperature, as it provides pessimistic numbers if the case temperature is measured in a non-standard system and junction temperatures are backed out. It can be used with  $\theta_{JB}$  in 1-dimensional thermal simulation of a package system.

$\theta_{JB}$  (Junction-to-Board Thermal Resistance) is defined to be the difference in the junction temperature and the PCB temperature at the center of the package (closest to the die) when the PCB is clamped in a cold-plate structure.  $\theta_{JB}$  is only defined for the high-k test card.

$\theta_{JB}$  provides an overall thermal resistance between the die and the PCB. It includes a bit of the PCB thermal resistance (especially for BGAs with thermal balls) and can be used for simple 1-dimensional network analysis of package system (see [图 11-2](#)).



**图 11-2. Thermal Resistance**

## 12 Device and Documentation Support

### 12.1 Device Support

#### 12.1.1 第三方产品免责声明

TI 发布的与第三方产品或服务有关的信息，不能构成与此类产品或服务或保修的适用性有关的认可，不能构成此类产品或服务单独或与任何 TI 产品或服务一起的表示或认可。

### 12.2 接收文档更新通知

要接收文档更新通知，请导航至 [ti.com](http://ti.com) 上的器件产品文件夹。点击 [订阅更新](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

### 12.3 支持资源

[TI E2E™ 支持论坛](#) 是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《使用条款》。

### 12.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

所有商标均为其各自所有者的财产。

### 12.5 静电放电警告



静电放电 (ESD) 会损坏这个集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

### 12.6 术语表

#### TI 术语表

本术语表列出并解释了术语、首字母缩略词和定义。

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

| Orderable part number            | Status<br>(1) | Material type<br>(2) | Package   Pins  | Package qty   Carrier | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|----------------------------------|---------------|----------------------|-----------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| <a href="#">SN65HVD3082ED</a>    | Obsolete      | Production           | SOIC (D)   8    | -                     | -           | Call TI                              | Call TI                           | -40 to 85    | VP3082              |
| <a href="#">SN65HVD3082EDGKR</a> | Active        | Production           | VSSOP (DGK)   8 | 2500   LARGE T&R      | Yes         | SN                                   | Level-1-260C-UNLIM                | -40 to 85    | NWN                 |
| SN65HVD3082EDGKR.A               | Active        | Production           | VSSOP (DGK)   8 | 2500   LARGE T&R      | Yes         | SN                                   | Level-1-260C-UNLIM                | -40 to 85    | NWN                 |
| <a href="#">SN65HVD3082EDR</a>   | Active        | Production           | SOIC (D)   8    | 2500   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 85    | VP3082              |
| SN65HVD3082EDR.A                 | Active        | Production           | SOIC (D)   8    | 2500   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 85    | VP3082              |
| SN65HVD3082EDRG4                 | Active        | Production           | SOIC (D)   8    | 2500   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 85    | VP3082              |
| <a href="#">SN65HVD3082EP</a>    | Active        | Production           | PDIP (P)   8    | 50   TUBE             | Yes         | NIPDAU                               | N/A for Pkg Type                  | -40 to 85    | 65HVD3082           |
| SN65HVD3082EP.A                  | Active        | Production           | PDIP (P)   8    | 50   TUBE             | Yes         | NIPDAU                               | N/A for Pkg Type                  | -40 to 85    | 65HVD3082           |
| SN65HVD3082EPE4                  | Active        | Production           | PDIP (P)   8    | 50   TUBE             | Yes         | NIPDAU                               | N/A for Pkg Type                  | -40 to 85    | 65HVD3082           |
| <a href="#">SN65HVD3085EDGKR</a> | Active        | Production           | VSSOP (DGK)   8 | 2500   LARGE T&R      | Yes         | SN                                   | Level-1-260C-UNLIM                | -40 to 85    | NWK                 |
| SN65HVD3085EDGKR.A               | Active        | Production           | VSSOP (DGK)   8 | 2500   LARGE T&R      | Yes         | SN                                   | Level-1-260C-UNLIM                | -40 to 85    | NWK                 |
| <a href="#">SN65HVD3085EDR</a>   | Active        | Production           | SOIC (D)   8    | 2500   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 85    | VP3085              |
| SN65HVD3085EDR.A                 | Active        | Production           | SOIC (D)   8    | 2500   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 85    | VP3085              |
| <a href="#">SN65HVD3088ED</a>    | Obsolete      | Production           | SOIC (D)   8    | -                     | -           | Call TI                              | Call TI                           | -40 to 85    | VP3088              |
| <a href="#">SN65HVD3088EDGKR</a> | Active        | Production           | VSSOP (DGK)   8 | 2500   LARGE T&R      | Yes         | SN                                   | Level-1-260C-UNLIM                | -40 to 85    | NWH                 |
| SN65HVD3088EDGKR.A               | Active        | Production           | VSSOP (DGK)   8 | 2500   LARGE T&R      | Yes         | SN                                   | Level-1-260C-UNLIM                | -40 to 85    | NWH                 |
| <a href="#">SN65HVD3088EDR</a>   | Active        | Production           | SOIC (D)   8    | 2500   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 85    | VP3088              |
| SN65HVD3088EDR.A                 | Active        | Production           | SOIC (D)   8    | 2500   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 85    | VP3088              |
| SN65HVD3088EDRG4                 | Active        | Production           | SOIC (D)   8    | 2500   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 85    | VP3088              |
| <a href="#">SN65HVD3088ENSR</a>  | Active        | Production           | SOP (NS)   14   | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 85    | HVD3088E            |
| SN65HVD3088ENSR.A                | Active        | Production           | SOP (NS)   14   | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 85    | HVD3088E            |
| <a href="#">SN75HVD3082ED</a>    | Obsolete      | Production           | SOIC (D)   8    | -                     | -           | Call TI                              | Call TI                           | 0 to 70      | VN3082              |
| <a href="#">SN75HVD3082EDGKR</a> | Active        | Production           | VSSOP (DGK)   8 | 2500   LARGE T&R      | Yes         | SN                                   | Level-1-260C-UNLIM                | 0 to 70      | NWM                 |
| SN75HVD3082EDGKR.A               | Active        | Production           | VSSOP (DGK)   8 | 2500   LARGE T&R      | Yes         | SN                                   | Level-1-260C-UNLIM                | 0 to 70      | NWM                 |
| <a href="#">SN75HVD3082EDR</a>   | Active        | Production           | SOIC (D)   8    | 2500   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | 0 to 70      | VN3082              |
| SN75HVD3082EDR.A                 | Active        | Production           | SOIC (D)   8    | 2500   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | 0 to 70      | VN3082              |
| SN75HVD3082EDR.B                 | Active        | Production           | SOIC (D)   8    | 2500   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | 0 to 70      | VN3082              |
| SN75HVD3082EDRG4                 | Active        | Production           | SOIC (D)   8    | 2500   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | 0 to 70      | VN3082              |
| <a href="#">SN75HVD3082EP</a>    | Active        | Production           | PDIP (P)   8    | 50   TUBE             | Yes         | NIPDAU                               | N/A for Pkg Type                  | 0 to 70      | 75HVD3082           |

| Orderable part number | Status<br>(1) | Material type<br>(2) | Package   Pins | Package qty   Carrier | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|-----------------------|---------------|----------------------|----------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| SN75HVD3082EP.A       | Active        | Production           | PDIP (P)   8   | 50   TUBE             | Yes         | NIPDAU                               | N/A for Pkg Type                  | 0 to 70      | 75HVD3082           |

- <sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).
- <sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.
- <sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.
- <sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.
- <sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.
- <sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

**Important Information and Disclaimer:**The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

## TAPE AND REEL INFORMATION



\*All dimensions are nominal

| Device           | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|------------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| SN65HVD3082EDGKR | VSSOP        | DGK             | 8    | 2500 | 330.0              | 12.4               | 5.25    | 3.35    | 1.25    | 8.0     | 12.0   | Q1            |
| SN65HVD3082EDR   | SOIC         | D               | 8    | 2500 | 330.0              | 12.4               | 6.4     | 5.2     | 2.1     | 8.0     | 12.0   | Q1            |
| SN65HVD3082EDR   | SOIC         | D               | 8    | 2500 | 330.0              | 12.4               | 6.4     | 5.2     | 2.1     | 8.0     | 12.0   | Q1            |
| SN65HVD3085EDGKR | VSSOP        | DGK             | 8    | 2500 | 330.0              | 12.4               | 5.25    | 3.35    | 1.25    | 8.0     | 12.0   | Q1            |
| SN65HVD3085EDR   | SOIC         | D               | 8    | 2500 | 330.0              | 12.4               | 6.4     | 5.2     | 2.1     | 8.0     | 12.0   | Q1            |
| SN65HVD3088EDGKR | VSSOP        | DGK             | 8    | 2500 | 330.0              | 12.4               | 5.25    | 3.35    | 1.25    | 8.0     | 12.0   | Q1            |
| SN65HVD3088EDR   | SOIC         | D               | 8    | 2500 | 330.0              | 12.4               | 6.4     | 5.2     | 2.1     | 8.0     | 12.0   | Q1            |
| SN65HVD3088ENSR  | SOP          | NS              | 14   | 2000 | 330.0              | 16.4               | 8.1     | 10.4    | 2.5     | 12.0    | 16.0   | Q1            |
| SN75HVD3082EDGKR | VSSOP        | DGK             | 8    | 2500 | 330.0              | 12.4               | 5.25    | 3.35    | 1.25    | 8.0     | 12.0   | Q1            |
| SN75HVD3082EDR   | SOIC         | D               | 8    | 2500 | 330.0              | 12.4               | 6.4     | 5.2     | 2.1     | 8.0     | 12.0   | Q1            |

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

| Device           | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| SN65HVD3082EDGKR | VSSOP        | DGK             | 8    | 2500 | 366.0       | 364.0      | 50.0        |
| SN65HVD3082EDR   | SOIC         | D               | 8    | 2500 | 340.5       | 338.1      | 20.6        |
| SN65HVD3082EDR   | SOIC         | D               | 8    | 2500 | 353.0       | 353.0      | 32.0        |
| SN65HVD3085EDGKR | VSSOP        | DGK             | 8    | 2500 | 366.0       | 364.0      | 50.0        |
| SN65HVD3085EDR   | SOIC         | D               | 8    | 2500 | 340.5       | 336.1      | 25.0        |
| SN65HVD3088EDGKR | VSSOP        | DGK             | 8    | 2500 | 366.0       | 364.0      | 50.0        |
| SN65HVD3088EDR   | SOIC         | D               | 8    | 2500 | 340.5       | 336.1      | 25.0        |
| SN65HVD3088ENSR  | SOP          | NS              | 14   | 2000 | 353.0       | 353.0      | 32.0        |
| SN75HVD3082EDGKR | VSSOP        | DGK             | 8    | 2500 | 366.0       | 364.0      | 50.0        |
| SN75HVD3082EDR   | SOIC         | D               | 8    | 2500 | 340.5       | 336.1      | 25.0        |

## TUBE



\*All dimensions are nominal

| Device          | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (μm) | B (mm) |
|-----------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| SN65HVD3082EP   | P            | PDIP         | 8    | 50  | 506    | 13.97  | 11230  | 4.32   |
| SN65HVD3082EP.A | P            | PDIP         | 8    | 50  | 506    | 13.97  | 11230  | 4.32   |
| SN65HVD3082EPE4 | P            | PDIP         | 8    | 50  | 506    | 13.97  | 11230  | 4.32   |
| SN75HVD3082EP   | P            | PDIP         | 8    | 50  | 506    | 13.97  | 11230  | 4.32   |
| SN75HVD3082EP.A | P            | PDIP         | 8    | 50  | 506    | 13.97  | 11230  | 4.32   |

# MECHANICAL DATA

NS (R-PDSO-G\*\*)

PLASTIC SMALL-OUTLINE PACKAGE

14-PINS SHOWN



| DIM \ PINS ** | 14    | 16    | 20    | 24    |
|---------------|-------|-------|-------|-------|
| A MAX         | 10,50 | 10,50 | 12,90 | 15,30 |
| A MIN         | 9,90  | 9,90  | 12,30 | 14,70 |

4040062/C 03/03

- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.

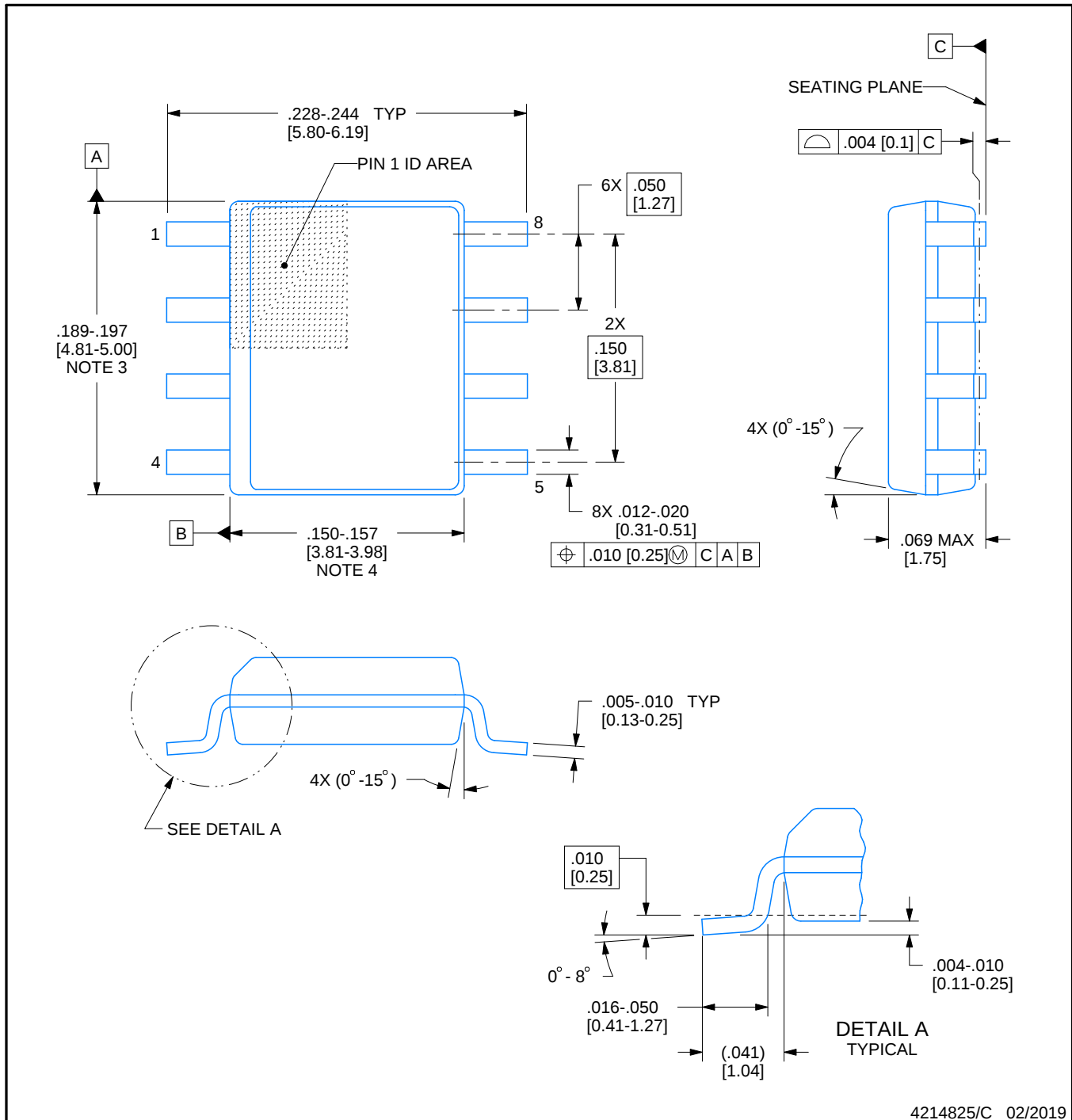


**D0008A**

# PACKAGE OUTLINE

**SOIC - 1.75 mm max height**

SMALL OUTLINE INTEGRATED CIRCUIT



4214825/C 02/2019

## NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.

**D0008A**

**SOIC - 1.75 mm max height**

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:8X



## SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

## EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE  
BASED ON .005 INCH [0.125 MM] THICK STENCIL  
SCALE:8X

4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

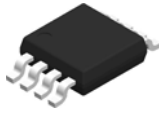
P (R-PDIP-T8)

PLASTIC DUAL-IN-LINE PACKAGE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  - C. Falls within JEDEC MS-001 variation BA.

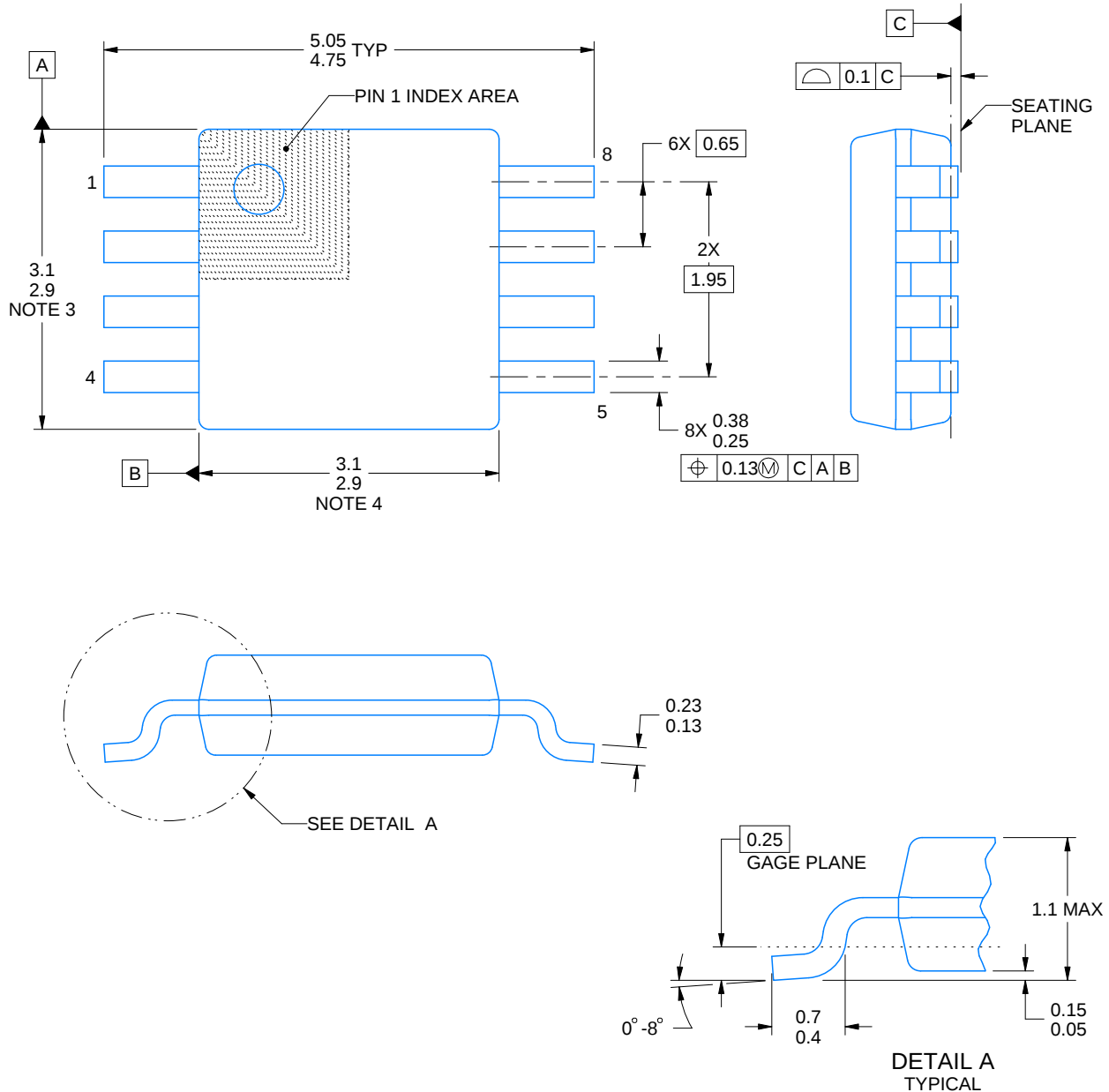
DGK0008A



# PACKAGE OUTLINE

## VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



4214862/A 04/2023

### NOTES:

PowerPAD is a trademark of Texas Instruments.

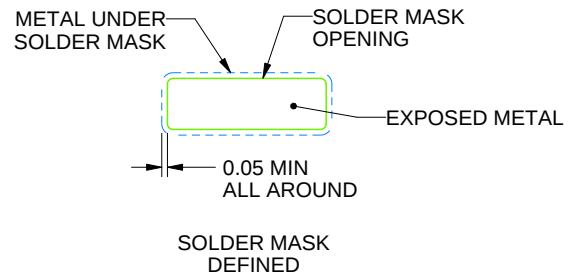
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187.

# EXAMPLE BOARD LAYOUT

DGK0008A

™ VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



SOLDER MASK DETAILS

4214862/A 04/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
9. Size of metal pad may vary due to creepage requirement.

## EXAMPLE STENCIL DESIGN

DGK0008A

<sup>TM</sup> VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
SCALE: 15X

4214862/A 04/2023

NOTES: (continued)

11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
12. Board assembly site may have different recommendations for stencil design.

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